


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538513	<b>Applicant(s)/Patent Under Reexamination</b>  MASHITANI ET AL.
	<b>Examiner</b>  SHEELA C CHAWAN	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
348	49, 56, 42, 44, 43, E13.014,E13.071,348/E13.014,E13.071,E13.033,E13.038,E13.022,"E13.029,E13.073,E13.025,E13.059,51,E13.064,E13.072,E13.04,E13.037,42,E13.058,E13.03,E13.049,E13.05,E13.061,E13.044,E13.062,E13.007,E13.008,E13.039,E13.034,E13.053,E13.048,578,580,E5.055,E13.005,E13.063,E13.043,E13.047,E13.051,E13.052	10/26/08	SCC
359	478,471, 464, 888, 900, 479, 462, 477, 480,	10/26/08	SCC
345	7, 419, 426,	"	"
378	41,	"	"
352	57,86, 213, 43, 60, 45,46	"	"
382	154	8/26/09	SCC
345	419	8/26/09	SCC
348	42	8/26/09	SCC
ABOVE SEARCH UP-DATE		8/26/09	SCC

SEARCH NOTES		
Search Notes	Date	Examiner
SEARCH EAST AND OTHER DATA BASE , SEE THE SEARCH HISTORY.	10/26/08	SCC
INVENTOR NAME SEARCH.	"	"
SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH HISTORY	8/26/09	SCC
382/154,214.ccls. US.PATENT TEXT SEARCH ONLY	8/26/09	SCC
345/419,426.CCLS. " " "	8/26/09	SCC
348/51,42.ccls. " " "	8/26/09	SCC
INTERFERENCE SEARCH	8/26/09	SCC
SEARCH IEEE OR INSPEC DATA BA SE.	8/26/09	SCC
ABOVE SEARCH UP-DATE	8/26/09	SCC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	154	8/26/09	SCC
345	419	8/26/09	SCC
348	42	8/26/09	SCC

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